

**Search Notes**

Application/Control No.

10/663,214

Examiner

Patrick Butler

Applicant(s)/Patent under  
Reexamination

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Art Unit

1732

**SEARCHED**

Class	Subclass	Date	Examiner
264	319	6/30/2005	PB
264	250	6/30/2005	PB
264	344	6/30/2005	PB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted Edmund Lee for 264	6/30/2005	PB
EAST (US-PGPUB, USPAT, PSOCR, EPO, JPO, DERWENT) - See search history printouts	6/30/2005	PB
conducted inventor search in PALM	7/5/2005	PB
264/328.1, 299, 261, 325 (cursory)	6/30/2005	PB